High Capacitance Tantalum Solid Electrolytic Chip Capacitors Undertab Series





FEATURES

- Large Case Size for Maximum Capacitance
- · 3x Reflow 260°C Compatible
- 100% Surge Current Tested
- · Low Profile Solution
- Consumer Applications (e.g. PCMCIA/USB Wireless Express Cards etc.)
- CV Range: 1000-3300µF / 4-10V
- 2 Case Sizes Available

APPLICATIONS

- · Data Transfer Modems
- SSD Backup Circuits





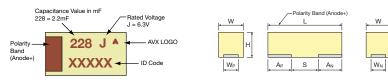
CASE DIMENSIONS:

millimeters (inches)

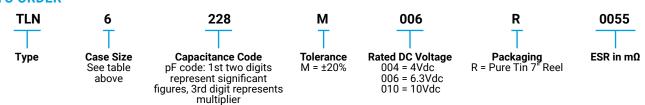
Code	EIA Code	EIA Metric	L±0.20 (0.008)	W+0.20 (0.008) -0.10 (0.004)	H max.	W _P ±0.10 (0.004)	W _N ±0.10 (0.004)	A _P ±0.10 (0.004)	A _N ±0.10 (0.004)	S Min.
4	2924	7361-20	7.30 (0.287)	6.10 (0.240)	2.00 (0.079)	4.75 (0.187)	4.75 (0.187)	2.00 (0.079)	3.20 (0.126)	2.10 (0.083)
6	5831	14878-20	14.80 (0.583)	7.80 (0.307)	2.00 (0.079)	5.50 (0.217)	5.50 (0.217)	2.45 (0.096)	2.45 (0.096)	9.90 (0.390)

MARKING

4,6 CASE



HOW TO ORDER



TECHNICAL SPECIFICATIONS

Technical Data:			All technical data relate to an ambient temperature of +25°C						
Capacitance Range: 1			1000 μF to 3300 μF						
Capacitance Tolerance: ±			±20%						
Leakage Current DCL:		0.01CV							
Rated Voltage (V _R)	-55°C ≤ +40°C:	4	6.3	10					
Category Voltage (V _c) at 85°C:		2	3.2	5					
Category Voltage (V _c) at 125°C:		0.8	1.3	2					
Temperature Range:			-55°C to +125°C with category voltage						
Reliability:		0.2% per 1000 hours at 85°C, $0.5xV_R$ with $0.1\Omega/V$ series impedance with 60%							
		confidence level							

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CAPACITANCE AND RATED VOLTAGE RANGE (LETTER DENOTES CASE SIZE)

Capac	itance	Voltage Rating DC (VR) to 85°C							
μF	Code	4V (G)	6.3V (J)	10V (A)					
680	687								
1000	108			4(100)/6(55)					
1500	158		4(100)	6(55)					
2200	228		6(55)						
3300	338	6(55)							

Released ratings (ESR ratings in mOhms in parentheses)

Note: Voltage ratings are minimum values. AVX reserves the right to supply

higher voltage ratings in the same case size, to the same reliability standards.

RATINGS & PART NUMBER REFERENCE

AVX	Case Size	Capacitance	Rated Voltage (V)	Rated Temperature (°C)	Category Voltage (V)	Category Temperature (°C)	DCL Max. (µA)	ESR Max.	100kHz RMS Current (mA)			
Part No.		(μ F)						@ 100kHz (mΩ)	25°C	85°C	125°C	MSL
4 Volt @ 40°C												
TLN6338M004#0055	6	3300	4	40	0.8	125	132	55	2045	1840	818	3
	6.3 Volt @ 40°C											
TLN4158M006#0100	4	1500	6.3	40	1.3	125	90	100	1285	1156	514	3
TLN6228M006#0055	6	2200	6.3	40	1.3	125	132	55	2045	1840	818	3
	10 Volt @ 40°C											
TLN4108M010#0100	4	1000	10	40	2	125	100	100	1285	1156	514	3
TLN6108M010#0055	6	1000	10	40	2	125	100	55	2045	1840	818	3
TLN6158M010#0055	6	1500	10	40	2	125	150	55	2045	1840	818	3

Moisture Sensitivity Level (MSL) is defined according to J-STD-020.

All technical data relates to an ambient temperature of +25°C. Capacitance and DF are measured at 120Hz, 0.5V RMS with a maximum DC bias of 2.2 volts.

DCL is measured at rated voltage after 5 minutes.

ESR allowed to move up to 1.25 times catalogue limit post mounting

DCL allowed to move up to 2.00 times catalogue limit post mounting

For typical weight and composition see page 259.

NOTE: AVX reserves the right to supply higher voltage ratings or tighter tolerance part in the same case size, to the same reliability standards.

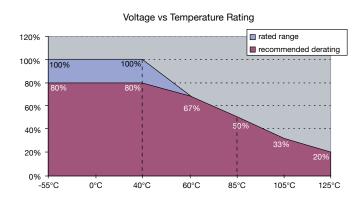
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QUALIFICATION TABLE

TEST	TLN PulseCap™ series (Temperature range -55°C to +125°C)												
IESI		Condition		Characteristics									
	Apply rated voltage	ge (Ur) at 40°C and	/ or category	Visual examination	Visual examination no visible damage								
Endurance		5°C for 2000 hours	DCL	2 x initial limit									
Endurance	· ·	.1Ω/V. Stabilize at re	ΔC/C	within +	within +5/-30% of initial value								
	for 1-2 hours befo	ore measuring.		ESR	1.25 x initial limit								
	Store at 65°C and	d 90-95% relative hu	Visual examination	no visib	no visible damage								
Llumaiditu		plied voltage. Stabi	DCL	2 x initia	2 x initial limit								
Humidity		humidity for 1-2 ho	ΔC/C	within ±	within ±10% of initial value								
	measuring.			ESR	1.25 x ir	1.25 x initial limit							
	Step 1	Temperature°C +20	Duration(min) 15	_	+20°C	-55°C	+20°C	+85°C	+125°C	+20°C			
Temperature	2	-55	15	DCL	2 x IL*	n/a	2 x IL*	20 x IL*	25 x IL*	2 x IL*			
Stability	3	+20 +85	15 15	ΔC/C	n/a	+5/-20%	±10%	+20/-0%	+25/-0%	±10%			
	5	+125	15	ESR	1.25xIL*				1.25 x IL*	-			
	6	+20	15					1.23 X IL	1.23 X IL	1.ZJXIL			
_		voltage (Ur) at 40°C		Visual examination		no visible damage							
Surge		(30 sec charge, 5 r		DCL		2 x initial limit							
Voltage	of 10000	gh a charge / discha	ΔC/C	within ±5% of initial value									
	01 100012			ESR		1.25 x initial limit							
				Visual examination	no visible damage								
Mechanical				DCL		initial limit							
Shock	MIL-STD-202, Me	thod 213, Condition	ΔC/C	within ±	within ±5% of initial value								
C.I.CO.I.				DF	initial lir	initial limit							
				ESR	initial lir	initial limit							
				Visual examination	no visible damage								
	MIL-STD-202, Method 204, Condition D			DCL	initial limit								
Vibration				ΔC/C	within ±	within ±5% of initial value							
			DF	initial lir	initial limit								
			ESR	initial limit									

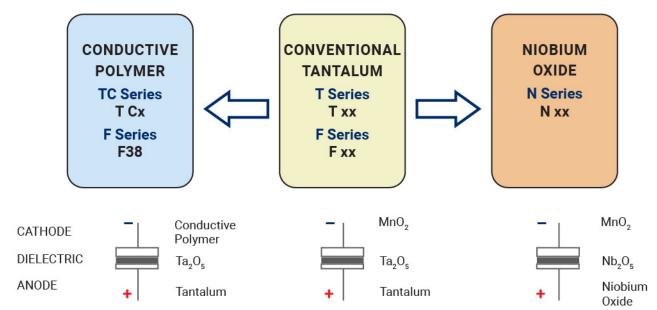
^{*}Initial Limit



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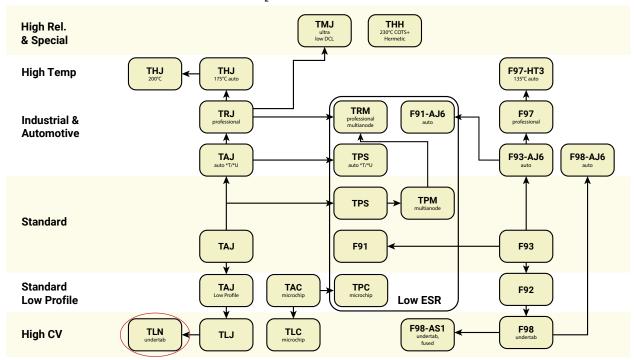
AVX SOLID ELECTROLYTIC CAPACITOR ROADMAP



FIVE CAPACITOR CONSTRUCTION STYLES



SERIES LINE UP: CONVENTIONAL SMD MnO,



Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Kyocera AVX:

<u>TLN4158M006R0100</u> <u>TLN6228M006R0055</u> <u>TLN6338M004R0055</u> <u>TLN6108M010R0055</u> <u>TLN6158M010R0055</u> TLN4108M010R0100